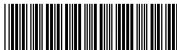


Search Notes**Application/Control No.**

10/536,734

Examiner

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**Applicant(s)/Patent under
Reexamination**

ITSKOVITZ-ELDOR ET AL.

Art Unit

1651

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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search	3/5/2009	TK